


<b>Search Notes</b>  	<b>Application/Control No.</b>  10740465	<b>Applicant(s)/Patent Under Reexamination</b>  BAEK ET AL.
	<b>Examiner</b>  Moon, Seokyun	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	698, 87, 98-100	09/22/2008	s.m.
348	556	09/22/2008	s.m.

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, JPO, EPO) Class 345 - Combined with Text Search	09/22/2008	s.m.
EAST (US-PGPUB, USPAT, JPO, EPO) Class 348 - Combined with Text Search	09/22/2008	s.m.
EAST (US-PGPUB, USPAT, EPO, JPO) - See Search History Printout		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
345	698, 98, 99	09/22/2008	s.m.
348	556	09/22/2008	s.m.

/S. M./  
Examiner, Art Unit 2629